

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10537590	LIU ET AL.
	Examiner	Art Unit
	Cehic, Kenan	2616

SEARCHED

Class	Subclass	Date	Examiner
370	235,230.1,231,236.1,236.2,389	12/31/2007	KC

SEARCH NOTES

Search Notes	Date	Examiner
Inventorship Search	12/31/2007	KC
Consulted with SPE Kwang Yao	12/26/2007	KC
Update search	10/9/2008	kc

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

--	--